- Function, Pinout, and Drive Compatible
  With FCT and F Logic
- Reduced V<sub>OH</sub> (Typically = 3.3 V) Versions of Equivalent FCT Functions
- Edge-Rate Control Circuitry for Significantly Improved Noise Characteristics
- I<sub>off</sub> Supports Partial-Power-Down Mode Operation
- Matched Rise and Fall Times
- ESD Protection Exceeds JESD 22
  - 2000-V Human-Body Model (A114-A)
  - 200-V Machine Model (A115-A)
  - 1000-V Charged-Device Model (C101)
- Fully Compatible With TTL Input and Output Logic Levels
- 64-mA Output Sink Current
  32-mA Output Source Current

#### **SO PACKAGE** (TOP VIEW) 16**∏** V<sub>CC</sub> S Q<sub>A</sub> [ 15 \ Q<sub>D</sub> 14 🛮 I<sub>0D</sub> I<sub>0A</sub> [ I<sub>1A</sub> 13 | I<sub>1D</sub> I<sub>1B</sub> [] 5 12 I I<sub>1C</sub> 11 I I<sub>0C</sub> I<sub>OB</sub> L 10 🛛 Q<sub>C</sub> $Q_B$ GND 8 9 CP

#### description

The CY74FCT399T is a high-speed quad 2-input register that selects four bits of data from either of two sources (ports) under control of a common select (S) input. Selected data are transferred to a 4-bit output register synchronous with the low-to-high transition of the clock (CP) input. The 4-bit D-type output register is fully edge triggered. The data inputs  $(I_{0X}, I_{1X})$  and S input must be stable only one setup time prior to, and hold time after, the low-to-high transition of CP for predictable operation. The CY74FCT399T has noninverted outputs.

This device is fully specified for partial-power-down applications using I<sub>off</sub>. The I<sub>off</sub> circuitry disables the outputs, preventing damaging current backflow through the device when it is powered down.

#### **PIN DESCRIPTION**

| NAME           | DESCRIPTION                            |
|----------------|--|
| S              | Common select input                    |
| СР             | Clock-pulse input (active rising edge) |
| I <sub>0</sub> | Data inputs from source 0              |
| I <sub>1</sub> | Data inputs from source 1              |
| Q              | Register noninverted outputs           |

#### ORDERING INFORMATION

| TA            | PACI      | (AGE†         | SPEED<br>(ns) | ORDERABLE<br>PART NUMBER | TOP-SIDE<br>MARKING |
|---------------|-----------|---------------|---------------|--------------------------|---------------------|
|               | SOIC - SO | Tube          | 6.1           | CY74FCT399CTSOC          | FCT399C             |
| –40°C to 85°C | 3010 - 30 | Tape and reel | 6.1           | CY74FCT399CTSOCT         | FC1399C             |
| -40 C to 65 C | SOIC - SO | Tube          | 7             | CY74FCT399ATSOC          | FCT399A             |
|               | 30IC = 30 | Tape and reel | 7             | CY74FCT399ATSOCT         | FC1399A             |

<sup>†</sup> Package drawings, standard packing quantities, thermal data, symbolization, and PCB design guidelines are available at www.ti.com/sc/package.



Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.

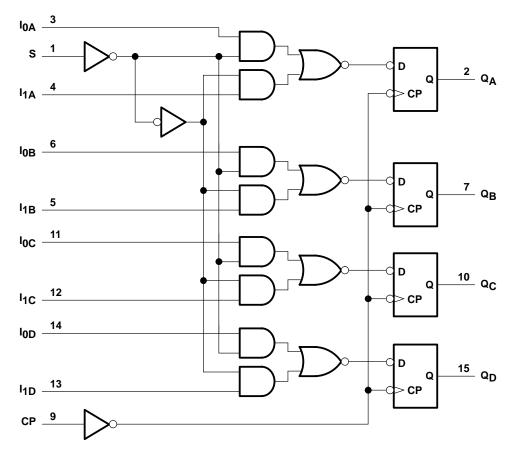


#### **FUNCTION TABLE**

|     | INPUTS         |                | OUTPUT |
|-----|----------------|----------------|--------|
| S   | l <sub>0</sub> | l <sub>1</sub> | Q      |
| - 1 | ı              | Χ              | L      |
| - 1 | h              | Χ              | Н      |
| h   | X              | I              | L      |
| h   | Χ              | h              | Н      |

H= High logic level, h= High logic level one setup time prior to the low-to-high clock transition, L= Low logic level, I= Low logic level one setup time prior to the low-to-high clock transition, X= Don't care

# logic diagram





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#### absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

| Supply voltage range to ground potential                     | 0.5 V to 7 V   |
|--|----------------|
| DC input voltage range                                       | 0.5 V to 7 V   |
| DC output voltage range                                      |                |
| DC output current (maximum sink current/pin)                 | 120 mA         |
| Package thermal impedance, θ <sub>JA</sub> (see Note 1)      |                |
| Ambient temperature range with power applied, T <sub>A</sub> | –65°C to 135°C |
| Storage temperature range, T <sub>stg</sub>                  | –65°C to 150°C |

<sup>†</sup> Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

#### recommended operating conditions (see Note 2)

|     |                                | MIN  | NOM | MAX  | UNIT |
|-----|--------------------------------|------|-----|------|------|
| Vcc | Supply voltage                 | 4.75 | 5   | 5.25 | V    |
| VIH | High-level input voltage       | 2    |     |      | V    |
| VIL | Low-level input voltage        |      |     | 0.8  | V    |
| IOH | High-level output current      |      |     | -32  | mA   |
| loL | Low-level output current       |      |     | 64   | mA   |
| TA  | Operating free-air temperature | -40  |     | 85   | °C   |

NOTE 2: All unused inputs of the device must be held at  $V_{\hbox{CC}}$  or GND to ensure proper device operation.

NOTE 1: The package thermal impedance is calculated in accordance with JESD 51-7.

# electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

| PARAMETER          |   | TEST CONDITIONS                                 |  | MIN | TYP <sup>†</sup> | MAX  | UNIT       |
|--------------------|---|---|--|-----|------------------|------|------------|
| VIK                | V <sub>CC</sub> = 4.75,   | I <sub>IN</sub> = -18 mA                        |  |     | -0.7             | -1.2 | V          |
| V                  | V 475   | I <sub>OH</sub> = -32 mA                        |  | 2   |                  |      | V          |
| VOH                | V <sub>CC</sub> = 4.75  | I <sub>OH</sub> = -15 mA                        |  | 2.4 | 3.3              |      | V          |
| V <sub>OL</sub>    | V <sub>CC</sub> = 4.75,   | I <sub>OL</sub> = 64 mA                         |  |     | 0.3              | 0.55 | V          |
| VH                 | All inputs  |   |  |     | 0.2              |      | V          |
| I <sub>I</sub>     | $V_{CC} = 5.25 \text{ V},$  | V <sub>IN</sub> = V <sub>CC</sub>               |  |     |                  | 5    | μΑ         |
| lін                | V <sub>CC</sub> = 5.25 V,   | V <sub>IN</sub> = 2.7 V                         |  |     |                  | ±1   | μΑ         |
| I <sub>IL</sub>    | V <sub>CC</sub> = 5.25 V,   | V <sub>IN</sub> = 0.5 V                         |  |     |                  | ±1   | μΑ         |
| los <sup>‡</sup>   | V <sub>CC</sub> = 5.25 V,   | V <sub>OUT</sub> = 0 V                          |  | -60 | -120             | -225 | mA         |
| loff               | $V_{CC} = 0 V$ ,  | V <sub>OUT</sub> = 4.5 V                        |  |     |                  | ±1   | μΑ         |
| lcc                | V <sub>CC</sub> = 5.25 V,   | $V_{IN} \le 0.2 V$ ,                            | $V_{IN} \ge V_{CC} - 0.2 \text{ V}$                                  |     | 0.1              | 0.2  | mA         |
| ΔlCC               | $V_{CC} = 5.25 \text{ V}, V_{IN} = 3$   | $6.4 \text{ V}$ , $f_1 = 0$ , Outputs ope       | n  |     | 0.5              | 2    | mA         |
| I <sub>CCD</sub> ¶ | $V_{CC} = 5.25 \text{ V}$ , One inp $V_{IN} \le 0.2 \text{ V}$ or $V_{IN} \ge \text{V}$ | out switching at 50% duty of CC - 0.2 V         | cycle, Outputs open,   |     | 0.06             | 0.12 | mA/<br>MHz |
|                    | V <sub>CC</sub> = 5.25 V,   | One input switching at f <sub>1</sub> = 5 MHz   | $V_{IN} \le 0.2 \text{ V or}$<br>$V_{IN} \ge V_{CC} - 0.2 \text{ V}$ |     | 0.7              | 1.4  |            |
| lc#                | $f_0 = 10 \text{ MHz},$   | at 50% duty cycle                               | V <sub>IN</sub> = 3.4 V or GND                                       |     | 1.2              | 3.4  | mA         |
| ıC"                | Outputs open,<br>S = Steady state   | Four inputs switching at f <sub>1</sub> = 5 MHz | $V_{IN} \le 0.2 \text{ V or}$<br>$V_{IN} \ge V_{CC} - 0.2 \text{ V}$ |     | 1.6              | 3.2  | IIIA       |
|                    |   | at 50% duty cycle                               | $V_{IN} = 3.4 \text{ V or GND}$                                      |     | 2.9              | 8.2  |            |
| C <sub>i</sub>     |   |   |  |     | 5                | 10   | pF         |
| Co                 |   |   |  |     | 9                | 12   | pF         |

<sup>&</sup>lt;sup>†</sup> Typical values are at  $V_{CC} = 5 \text{ V}$ ,  $T_A = 25^{\circ}\text{C}$ .

 $^{\#}$ I<sub>C</sub> = I<sub>CC</sub> +  $\Delta$ I<sub>CC</sub> × D<sub>H</sub> × N<sub>T</sub> + I<sub>CCD</sub> (f<sub>0</sub>/2 + f<sub>1</sub> × N<sub>1</sub>)

Where:

I<sub>C</sub> = Total supply current

ICC = Power-supply current with CMOS input levels

 $\Delta I_{CC}$  = Power-supply current for a TTL high input ( $V_{IN}$  = 3.4 V)

D<sub>H</sub> = Duty cycle for TTL inputs high N<sub>T</sub> = Number of TTL inputs at D<sub>H</sub>

I<sub>CCD</sub> = Dynamic current caused by an input transition pair (HLH or LHL)

f<sub>0</sub> = Clock frequency for registered devices, otherwise zero

f<sub>1</sub> = Input signal frequency

N<sub>1</sub> = Number of inputs changing at f<sub>1</sub>

All currents are in milliamperes and all frequencies are in megahertz.

Values for these conditions are examples of the I<sub>CC</sub> formula.



Not more than one output should be shorted at a time. Duration of short should not exceed one second. The use of high-speed test apparatus and/or sample-and-hold techniques are preferable to minimize internal chip heating and more accurately reflect operational values. Otherwise, prolonged shorting of a high output can raise the chip temperature well above normal and cause invalid readings in other parametric tests. In any sequence of parameter tests, Ios tests should be performed last.

<sup>§</sup> Per TTL-driven input (V<sub>IN</sub> = 3.4 V); all other inputs at V<sub>CC</sub> or GND

This parameter is derived for use in total power-supply calculations.

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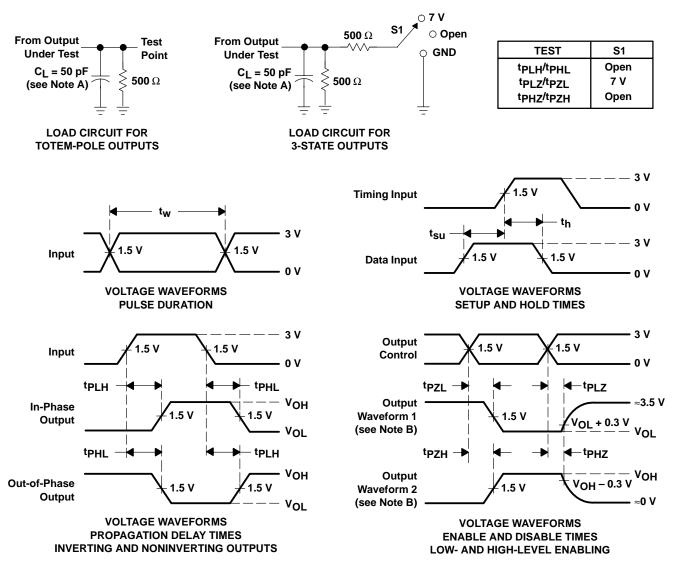
# timing requirement over recommended operating free-air temperature range (unless otherwise noted) (see Figure 1)

|                 |                                |                           | CY74FC1 | 399AT | CY74FCT | 399CT | UNIT |
|-----------------|--------------------------------|---------------------------|---------|-------|---------|-------|------|
|                 |                                |                           | MIN     | MAX   | MIN     | MAX   | UNIT |
| t <sub>W</sub>  | Pulse duration, CP high or low |                           | 5       |       | 5       |       | ns   |
|                 | Catura time a bimb and and     | I <sub>n</sub> before CP↑ | 3.5     |       | 3.5     |       |      |
| t <sub>su</sub> | Setup time, high or low        | S before CP↑              | 8.5     |       | 8.5     |       | ns   |
| Ţ.,             | Hold time high or low          | I <sub>n</sub> after CP↑  | 1       |       | 1       |       | no   |
| t <sub>h</sub>  | Hold time, high or low         | S after CP↑               | 0       |       | 0       |       | ns   |

## switching characteristics over operating free-air temperature range (see Figure 1)

| PARAMETER        | FROM    | то       | CY74FC | Г399АТ | CY74FC1 | T399CT | UNIT |
|------------------|---------|----------|--------|--------|---------|--------|------|
| PARAMETER        | (INPUT) | (OUTPUT) | MIN    | MAX    | MIN     | MAX    | UNIT |
| <sup>t</sup> PLH | СР      | _        | 2.5    | 7      | 2.5     | 6.1    | no   |
| t <sub>PHL</sub> | CF      | l Q      | 2.5    | 7      | 2.5     | 6.1    | ns   |

#### PARAMETER MEASUREMENT INFORMATION



NOTES: A. C<sub>I</sub> includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
- C. The outputs are measured one at a time with one input transition per measurement.

Figure 1. Load Circuit and Voltage Waveforms









#### **PACKAGING INFORMATION**

| Orderable Device   | Status <sup>(1)</sup> | Package<br>Type | Package<br>Drawing | Pins | Package<br>Qty | e Eco Plan <sup>(2)</sup> | Lead/Ball Finish | MSL Peak Temp <sup>(3)</sup> |
|--------------------|-----------------------|-----------------|--------------------|------|----------------|---------------------------|------------------|------------------------------|
| CY74FCT399ATQCT    | ACTIVE                | SSOP/<br>QSOP   | DBQ                | 16   | 2500           | Green (RoHS & no Sb/Br)   | CU NIPDAU        | Level-2-260C-1 YEAR          |
| CY74FCT399ATQCTE4  | ACTIVE                | SSOP/<br>QSOP   | DBQ                | 16   | 2500           | Green (RoHS & no Sb/Br)   | CU NIPDAU        | Level-2-260C-1 YEAR          |
| CY74FCT399ATQCTG4  | ACTIVE                | SSOP/<br>QSOP   | DBQ                | 16   | 2500           | Green (RoHS & no Sb/Br)   | CU NIPDAU        | Level-2-260C-1 YEAR          |
| CY74FCT399ATSOC    | ACTIVE                | SOIC            | DW                 | 16   | 40             | Green (RoHS & no Sb/Br)   | CU NIPDAU        | Level-1-260C-UNLIM           |
| CY74FCT399ATSOCE4  | ACTIVE                | SOIC            | DW                 | 16   | 40             | Green (RoHS & no Sb/Br)   | CU NIPDAU        | Level-1-260C-UNLIM           |
| CY74FCT399ATSOCG4  | ACTIVE                | SOIC            | DW                 | 16   | 40             | Green (RoHS & no Sb/Br)   | CU NIPDAU        | Level-1-260C-UNLIM           |
| CY74FCT399ATSOCT   | ACTIVE                | SOIC            | DW                 | 16   | 2000           | Green (RoHS & no Sb/Br)   | CU NIPDAU        | Level-1-260C-UNLIM           |
| CY74FCT399ATSOCTE4 | ACTIVE                | SOIC            | DW                 | 16   | 2000           | Green (RoHS & no Sb/Br)   | CU NIPDAU        | Level-1-260C-UNLIM           |
| CY74FCT399ATSOCTG4 | ACTIVE                | SOIC            | DW                 | 16   | 2000           | Green (RoHS & no Sb/Br)   | CU NIPDAU        | Level-1-260C-UNLIM           |
| CY74FCT399CTQCT    | ACTIVE                | SSOP/<br>QSOP   | DBQ                | 16   | 2500           | Green (RoHS & no Sb/Br)   | CU NIPDAU        | Level-2-260C-1 YEAR          |
| CY74FCT399CTQCTE4  | ACTIVE                | SSOP/<br>QSOP   | DBQ                | 16   | 2500           | Green (RoHS & no Sb/Br)   | CU NIPDAU        | Level-2-260C-1 YEAR          |
| CY74FCT399CTQCTG4  | ACTIVE                | SSOP/<br>QSOP   | DBQ                | 16   | 2500           | Green (RoHS & no Sb/Br)   | CU NIPDAU        | Level-2-260C-1 YEAR          |
| CY74FCT399CTSOC    | ACTIVE                | SOIC            | DW                 | 16   | 40             | Green (RoHS & no Sb/Br)   | CU NIPDAU        | Level-1-260C-UNLIM           |
| CY74FCT399CTSOCE4  | ACTIVE                | SOIC            | DW                 | 16   | 40             | Green (RoHS & no Sb/Br)   | CU NIPDAU        | Level-1-260C-UNLIM           |
| CY74FCT399CTSOCG4  | ACTIVE                | SOIC            | DW                 | 16   | 40             | Green (RoHS & no Sb/Br)   | CU NIPDAU        | Level-1-260C-UNLIM           |
| CY74FCT399CTSOCT   | ACTIVE                | SOIC            | DW                 | 16   | 2000           | Green (RoHS & no Sb/Br)   | CU NIPDAU        | Level-1-260C-UNLIM           |
| CY74FCT399CTSOCTE4 | ACTIVE                | SOIC            | DW                 | 16   | 2000           | Green (RoHS & no Sb/Br)   | CU NIPDAU        | Level-1-260C-UNLIM           |
| CY74FCT399CTSOCTG4 | ACTIVE                | SOIC            | DW                 | 16   | 2000           | Green (RoHS & no Sb/Br)   | CU NIPDAU        | Level-1-260C-UNLIM           |

<sup>&</sup>lt;sup>(1)</sup> The marketing status values are defined as follows:

**ACTIVE:** Product device recommended for new designs.

**LIFEBUY:** TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

**NRND:** Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

TBD: The Pb-Free/Green conversion plan has not been defined.

**Pb-Free** (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

Pb-Free (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and

<sup>(2)</sup> Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.



#### PACKAGE OPTION ADDENDUM

21-May-2007

package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

(3) MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

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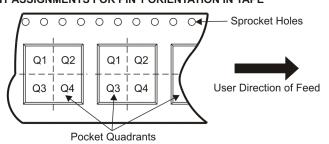
#### TAPE AND REEL INFORMATION





|    | Dimension designed to accommodate the component width     |
|----|---|
| B0 | Dimension designed to accommodate the component length    |
| K0 | Dimension designed to accommodate the component thickness |
| W  | Overall width of the carrier tape                         |
| P1 | Pitch between successive cavity centers                   |

QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



#### \*All dimensions are nominal

| Device           |      | Package<br>Drawing |    | SPQ  | Reel<br>Diameter<br>(mm) | Reel<br>Width<br>W1 (mm) | A0 (mm) | B0 (mm) | K0 (mm) | P1<br>(mm) | W<br>(mm) | Pin1<br>Quadrant |
|------------------|------|--------------------|----|------|--------------------------|--------------------------|---------|---------|---------|------------|-----------|------------------|
| CY74FCT399ATSOCT | SOIC | DW                 | 16 | 2000 | 330.0                    | 16.4                     | 10.75   | 10.7    | 2.7     | 12.0       | 16.0      | Q1               |
| CY74FCT399CTSOCT | SOIC | DW                 | 16 | 2000 | 330.0                    | 16.4                     | 10.75   | 10.7    | 2.7     | 12.0       | 16.0      | Q1               |





\*All dimensions are nominal

| Device           | Package Type | Package Drawing | Pins | SPQ  | Length (mm) | Width (mm) | Height (mm) |
|------------------|--------------|-----------------|------|------|-------------|------------|-------------|
| CY74FCT399ATSOCT | SOIC         | DW              | 16   | 2000 | 346.0       | 346.0      | 33.0        |
| CY74FCT399CTSOCT | SOIC         | DW              | 16   | 2000 | 346.0       | 346.0      | 33.0        |

# DW (R-PDSO-G16)

# PLASTIC SMALL-OUTLINE PACKAGE



NOTES:

- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion not to exceed 0.006 (0,15).
- D. Falls within JEDEC MS-013 variation AA.



# DBQ (R-PDSO-G16)

## PLASTIC SMALL-OUTLINE PACKAGE



NOTES:

- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion not to exceed 0.006 (0,15) per side.
- D. Falls within JEDEC MO-137 variation AB.



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